

High-reliability discrete products and engineering services since 1977

HR FLOW

TRANSIENT VOLTAGE SUPPRESSORS

All parts are screened per MIL-PRF-19500, JANTX Level and the device detail specification. All testing is performed at room temperature, unless indicated otherwise. For testing at high and low temperatures, Group A testing is required.

	Test	Method	Conditions / Notes
1	Temperature Cycling	MIL-STD-750 Method 1051	Test condition C or maximum storage temperature, whichever less. 20 cycles, 10 minutes per extreme.
2	Current Surge Peak Pulse Current (I _P)	10/1000μs peak current (I_P)	10 surges in each direction or as specified in detail specification.
3	Interim Electrical Testing		Per device detail specification.
4	Power Burn-in	MIL-STD-750 Method 1038	Condition B, 96 hours minimum. 48 hours in each polarity for bidirectional.
5	Final Electrical Testing		Per device detail specification.
6	Delta Calculation		Per device detail specification.
7	PDA Calculation		10 percent defective allowed.
8	Seal Test Gross Leak	MIL-STD-750 Method 1071	No bubbles present.

Notes:

- 1. Testing varies in accordance with the device detail specification.
- 2. Specific customer testing needs may be accommodated into any testing flow (selection tests, temperature requirements, special tests).